## Supporting Information for

## Flexible and Free-Standing Hetero-electrocatalyst of High-Valence-

## Cation Doped MoS<sub>2</sub>/MoO<sub>2</sub>/CNT Foam with Synergistically Enhanced

## Hydrogen Evolution Reaction Catalytic Activity

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**Fig. S1** Raman scan curve at different doping concentrations. As shown in the figure, the peak position and number of peaks hardly change with the change of doping concentration.



Fig. S2 X-ray photoelectron spectroscopy (XPS) of W-doped MoS<sub>2</sub>/MoO<sub>2</sub>/CNT foam.



Fig. S3 X-ray photoelectron spectroscopy (XPS) of a)Mo 3d, b)O 1s , c)S 2p and W 4f in 2% W-doped  $MoS_2/MoO_2/CNT$  foam and non-doped  $MoS_2/MoO_2/CNT$  foam.



Fig. S4 Energy-dispersive spectroscopy (EDS) elemental mapping of Mo, O, S and Wo in 2%W-doped MoS<sub>2</sub>/MoO<sub>2</sub>/CNT foam and non-doped MoS<sub>2</sub>/MoO<sub>2</sub>/CNT foam.



Fig. S5 Electrochemical properties of W-doped  $MoS_2/MoO_2/CNT$  foam. a) Comparison of bulk  $MoS_2/CNT$  foam and  $MoS_2/MoO_2/CNT$  foam prepared by our experimental method,

proving that our method method is effective. b) Performance obtained by doping different concentrations of W atoms, best performance at 2%.



**Fig. S6** Electrochemical impedance spectroscopy (EIS) data of samples under different conditions. Because the surface area is different, the absolute values cannot be compared, but it can be seen that the charge transfer impedance of the sample obtained by our method is very small.

Name	Start BE	Peak BE	End BE	Atomic %	PP At. %
W 4f	47.78	37.18	30.68	0.24	0.12
S 2p	171.98	162.45	159.48	3.84	2.61
Mo 3d	238.88	229.59	224.18	1.99	1.09
C 1s	295.38	284.81	282.18	88.21	93.78
O 1s	540.18	532	527.68	5.72	2.4

Table S1. XPS determined Mo, W, S, C and O atoms amounts in 2%W-doped sample.

Table S2. EDS determined C, O, S, Cu, Mo and W atoms amounts in 2%W-doped sample.

Element	Weight %	Atomic %
C(K)	33.35	75.83
O(K)	1.38	2.35
S(K)	1.80	1.53
Cu(K)	15.33	6.58

Mo(K)	47.99	13.66
W(L)	0.14	0.02

Table S3. ICP determined Mo, W, S and O atoms amounts in 2%W-doped sample.

Sample	Mo(at.%)	W(at.%)	<b>S(at.%)</b>	<b>O(at.%)</b>	Mo/W	
2%W-doped	33.17	0.48	4.90	61.44	69.1	

**Table S4.** Formation energies of W atom substituted Mo atom at edge and basal plane ofMoS2 under the S-rich or Mo-rich condition.

		$W_{Mo}$ doping Structure	Formation energy of $W_{Mo}$ doping (eV)
edge	W <sub>edge-Mo</sub>		-2.94 (S-rich) -0.30 (Mo-rich)
	W <sub>edge-1</sub>		-2.74 (S-rich) -0.10 (Mo-rich)
	W <sub>edge-2</sub>		-2.76 (S-rich) -0.12 (Mo-rich)
	W <sub>edge-3</sub>		-2.74 (S-rich) -0.10 (Mo-rich)
	W <sub>edge-S</sub>		-2.95 (S-rich) -0.31 (Mo-rich)
basal plane	W <sub>plane</sub>		-2.35 (S-rich) 0.29 (Mo-rich)